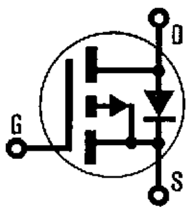
Data Sheet No. PD-9.461A

INTERNATIONAL RECTIFIER IOR

T-39-19

HEXFET® TRANSISTORS IRF9Z20 IRF9Z22

P-CHANNEL 50 VOLT POWER MOSFETs



-50 Volt, 0.28 Ohm, HEXFET TO-220AB Plastic Package

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of the HEXFET design achieve very low on-state resistance combined with high transconductance and extreme device ruggedness.

The P-Channel HEXFETs are designed for application which require the convenience of reverse polarity operation. They retain all of the features of the more common N-Channel HEXFETs such as voltage control, very fast switching, ease of paralleling, and excellent temperature stability.

P-Channel HEXFETs are intended for use in power stages where complementary symmetry with N-Channel devices offers circuit simplification. They are also very useful in drive stages because of the circuit versatility offered by the reverse polarity connection. Applications include motor control, audio amplifiers, switched mode converters, control circuits and pulse amplifiers.

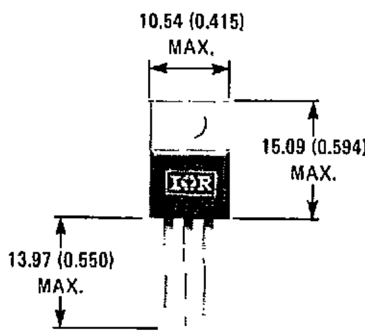
Product Summary

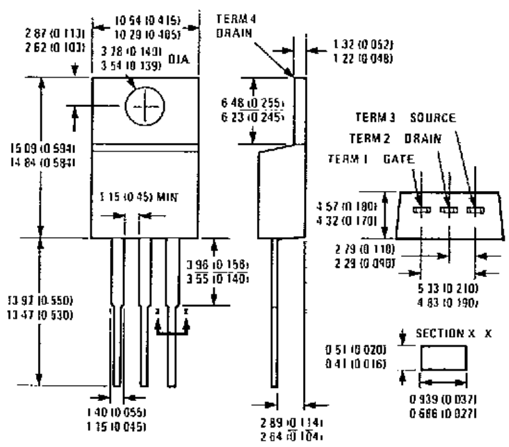
Part Number	V_{DS}	$R_{DS(on)}$	I_D
IRF9Z20	-50V	0.28Ω	-9.7A
IRF9Z22	-50V	0.33Ω	-8.9A

Features:

- P-Channel Versatility
- Compact Plastic Package
- Fast Switching
- Low Drive Current
- Ease of Paralleling
- Excellent Temperature Stability

CASE STYLE AND DIMENSIONS





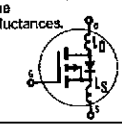
Case Style TO-220AB
Dimensions in Millimeters and (Inches)

Absolute Maximum Ratings

	Parameter	IRF9Z20	IRF9Z22	Units
V_{DS}	Drain - Source Voltage ①	−50	−50	V
V_{DGR}	Drain - Gate Voltage (R_{GS} = 20 KΩ) ①	−50	−50	V
I_D @ T_C = 25°C	Continuous Drain Current	−9.7	−8.9	A
I_D @ T_C = 100°C	Continuous Drain Current	−6.1	−5.6	A
I_{DM}	Pulsed Drain Current ③	−39	−36	A
V_{GS}	Gate - Source Voltage	±20		V
P_D @ T_C = 25°C	Max. Power Dissipation	40		W
	Linear Derating Factor	0.32		W/K ⑤
I_{LM}	Inductive Current, Clamped	−39 (See Fig. 14) L = 100μH	−36	A
I_L	Unclamped Inductive Current (Avalanche Current) ③	(See Fig. 15) −2.2		A
T_J T_{stg}	Operating Junction and Storage Temperature Range	−55 to 150		°C
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)		°C

Electrical Characteristics @ T_C = 25°C (Unless Otherwise Specified)

	Parameter	Type	Min.	Typ.	Max.	Units	Test Conditions
BV_{DSS}	Drain - Source Breakdown Voltage	IRF9Z20	−50	—	—	V	V_{GS} = 0V
		IRF9Z22					I_D = −250 μA
$V_{GS(th)}$	Gate Threshold Voltage	ALL	−2.0	—	−4.0	V	V_{DS} = V_{GS}, I_D = −250 μA
I_{GSS}	Gate-Source Leakage Forward	ALL	—	—	−500	nA	V_{GS} = −20V
I_{GSS}	Gate-Source Leakage Reverse	ALL	—	—	500	nA	V_{GS} = 20V
I_{DSS}	Zero Gate Voltage Drain Current	ALL	—	—	−250	μA	V_{DS} = Max. Rating, V_{GS} = 0V
			—	—	−1000	μA	V_{DS} = Max. Rating × 0.8, V_{GS} = 0V, T_C = 125°C
$I_{D(on)}$	On-State Drain Current ④	IRF9Z20	−9.7	—	—	A	V_{DS} > $I_{D(on)}$ × $R_{DS(on)max.}$, V_{GS} = −10V
		IRF9Z22	−8.9	—	—	A	
$R_{DS(on)}$	Static Drain-Source On-State Resistance ④	IRF9Z20	—	0.20	0.28	Ω	V_{GS} = −10V, I_D = −5.6A
		IRF9Z22	—	0.28	0.33	Ω	
g_{fs}	Forward Transconductance ④	ALL	2.3	3.5	—	S(℧)	V_{DS} = 2 × V_{GS}, I_{DS} = −5.6A
C_{iss}	Input Capacitance	ALL	—	480		pF	V_{GS} = 0V, V_{DS} = −25V, f = 1.0 MHz
C_{oss}	Output Capacitance	ALL	—	320		pF	See Fig. 10
C_{rss}	Reverse Transfer Capacitance	ALL	—	58		pF	
$t_{d(on)}$	Turn-On Delay Time	ALL	—	8.2	12	ns	V_{DD} = −25V, I_D ≈ −9.7A, R_G = 18Ω, R_D = 2.4Ω
t_r	Rise Time	ALL	—	57	86	ns	See Fig. 16
$t_{d(off)}$	Turn-Off Delay Time	ALL	—	12	18	ns	(MOSFET switching times are essentially independent of operating temperature.)
t_f	Fall Time	ALL	—	25	38	ns	
Q_g	Total Gate Charge (Gate-Source Plus Gate-Drain)	ALL	—	17	26	nC	V_{GS} = −10V, I_D = −9.7A, V_{DS} = 0.8 Max. Rating. See Fig. 17 for test circuit. (Gate charge is essentially independent of operating temperature.)
Q_{gs}	Gate-Source Charge	ALL	—	4.1	6.2	nC	
Q_{gd}	Gate-Drain ("Miller") Charge	ALL	—	5.7	8.6	nC	
L_D	Internal Drain Inductance	ALL	—	4.5	—	nH	Measured from the drain lead, 6mm (0.25 in.) from package to center of die. — Modified MOSFET symbol showing the internal inductances. device
L_S	Internal Source Inductance	ALL	—	7.5	—	nH	Measured from the source lead, 6mm (0.25 in.) from package to source bonding pad.



Thermal Resistance

R_{thJC}	Junction-to-Case	ALL	—	—	3.1	K/W⑤	
R_{thCS}	Case-to-Sink	ALL	—	1.0	—	K/W⑤	Mounting surface flat, smooth, and greased.
R_{thJA}	Junction-to-Ambient	ALL	—	—	80	K/W⑤	Typical socket mount

IRF9Z20, IRF9Z22 Devices

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Source-Drain Diode Ratings and Characteristics

I_S	Continuous Source Current (Body Diode)	IRF9Z20	—	—	−9.7	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier. 
		IRF9Z20	—	—	−8.9	A	
I_{SM}	Pulse Source Current (Body Diode) ③	IRF9Z22	—	—	−39	A	
		IRF9Z22	—	—	−36	A	
V_{SD}	Diode Forward Voltage ②	ALL	—	—	−6.3	V	T_C = 25°C, I_S = −9.7A, V_{GS} = 0V
t_{rr}	Reverse Recovery Time	ALL	56	110	280	ns	T_J = 25°C, I_F = −9.7A, dI_F/dt = 100A/μs
Q_{RR}	Reverse Recovered Charge	ALL	0.17	0.34	0.85	μC	T_J = 25°C, I_F = −9.7A, dI_F/dt = 100A/μs
t_{on}	Forward Turn-on Time	ALL	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.				

①T_J = 25°C to 150°C ③K/W = °C/W W/K = W/°C

② Repetitive Rating: Pulse width limited by max. junction temperature. See Transient Thermal Impedance Curve (Fig. 5).

③ @ V_{dd} = −25V, T_J = 25°C L = 100 μH, R_G = 25Ω

④ Pulse Test: Pulse width ≤ 300 μs, Duty Cycle ≤ 2%

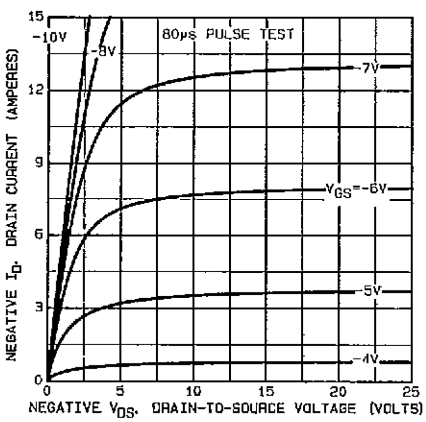

Fig. 1 — Typical Output Characteristics

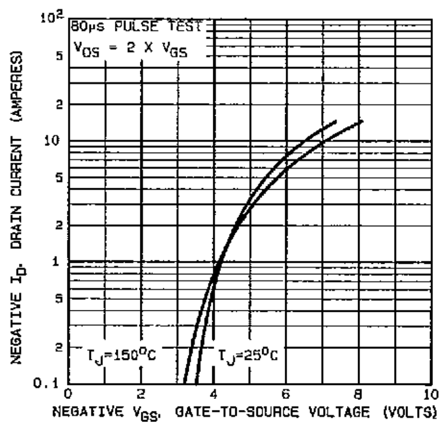

Fig. 2 — Typical Transfer Characteristics

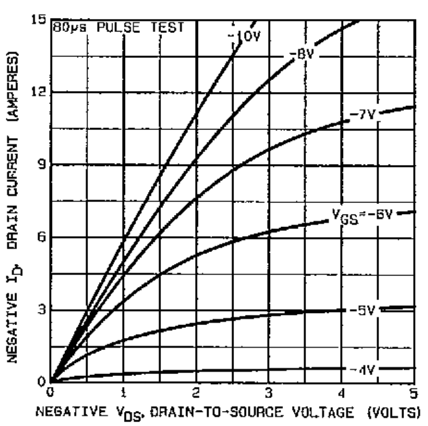

Fig. 3 — Typical Saturation Characteristics

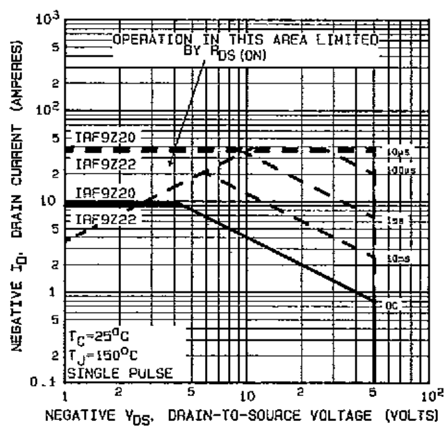

Fig. 4 — Maximum Safe Operating Area

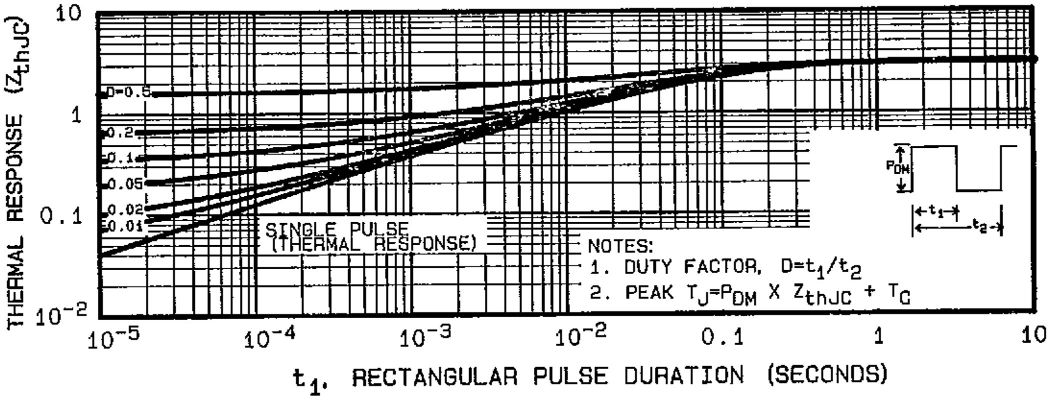

Fig. 5 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

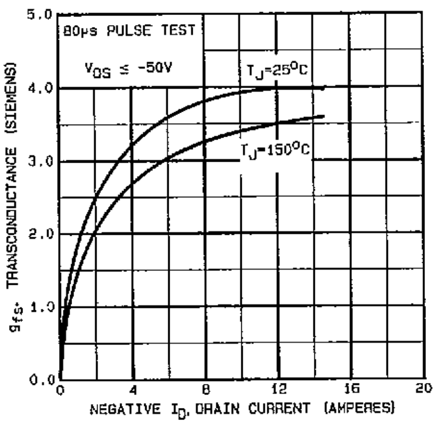

Fig. 6 — Typical Transconductance Vs. Drain Current

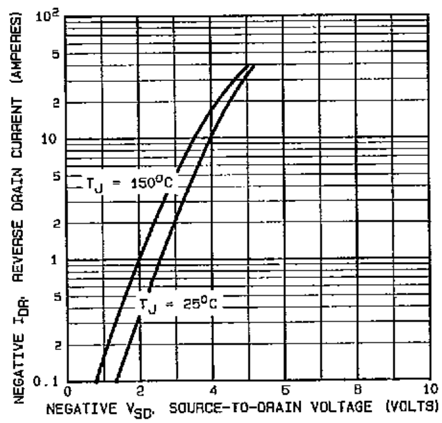

Fig. 7 — Typical Source-Drain Diode Forward Voltage

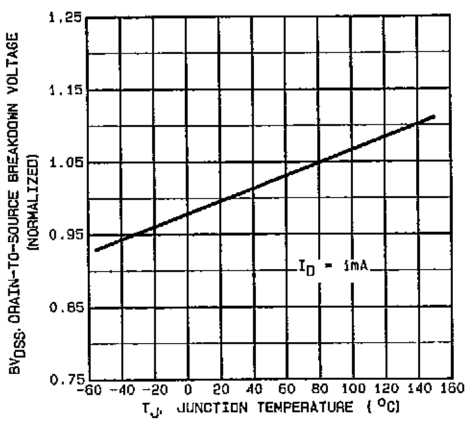

Fig. 8 — Breakdown Voltage Vs. Temperature

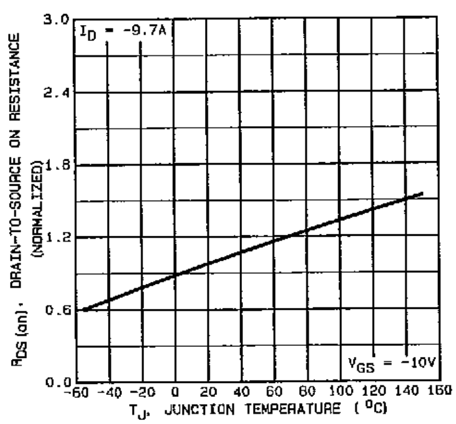

Fig. 9 — Normalized On-Resistance Vs. Temperature

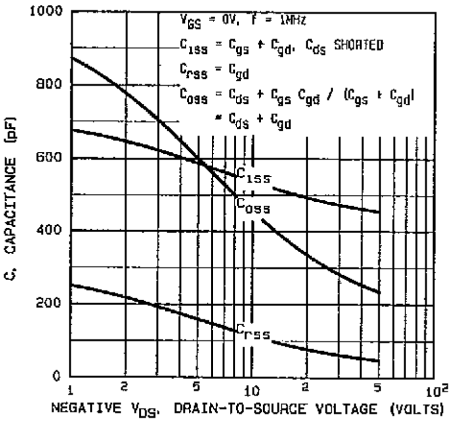

Fig. 10 — Typical Capacitance Vs. Drain-to-Source Voltage

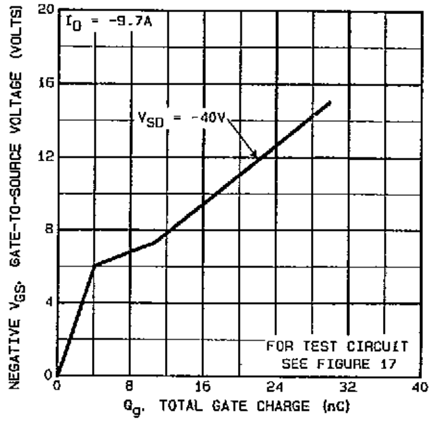

Fig. 11 — Typical Gate Charge Vs. Gate-to-Source Voltage

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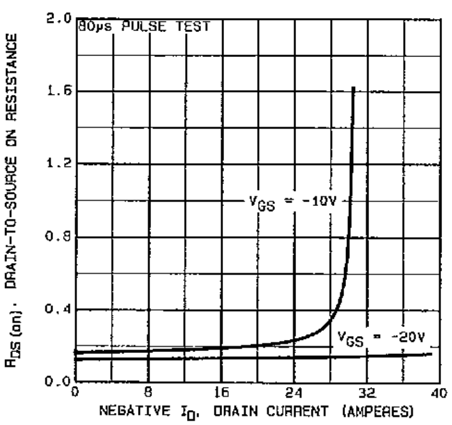

Fig. 12 — Typical On-Resistance Vs. Drain Current

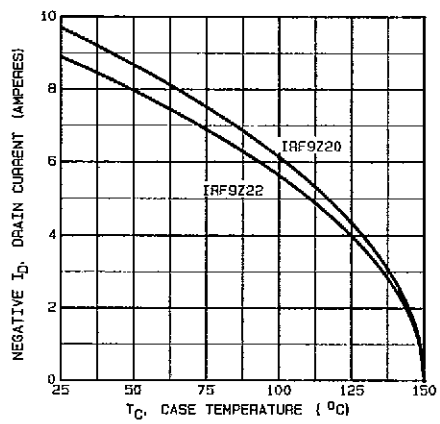

Fig. 13 — Maximum Drain Current Vs. Case Temperature

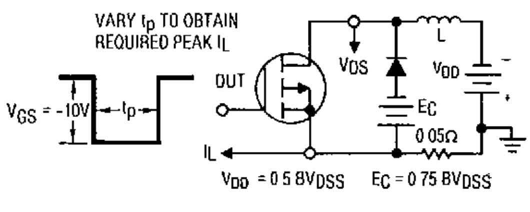

Fig. 14a — Clamped Inductive Test Circuit

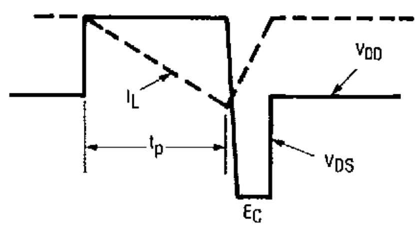

Fig. 14b — Clamped Inductive Waveforms

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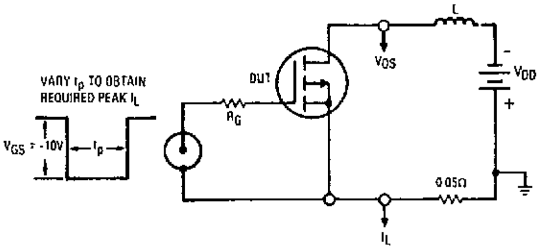

Fig. 15a — Unclamped Inductive Test Circuit

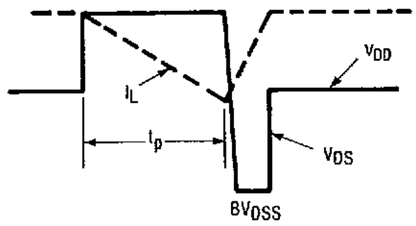

Fig. 15b — Unclamped Inductive Load Test Waveforms

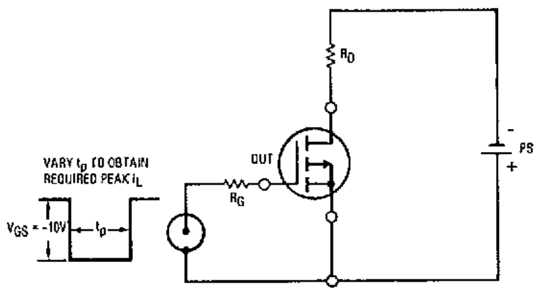

Fig. 16 — Switching Time Test Circuit

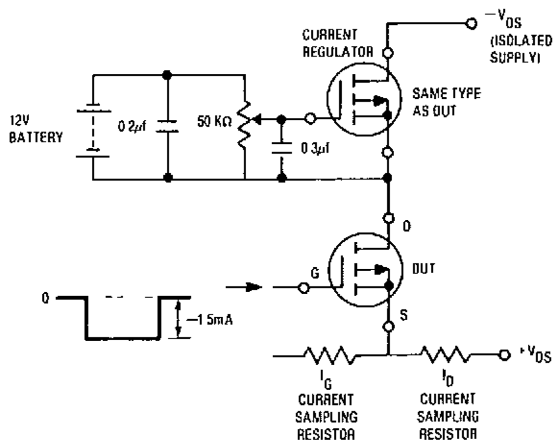

Fig. 17 — Gate Charge Test Circuit

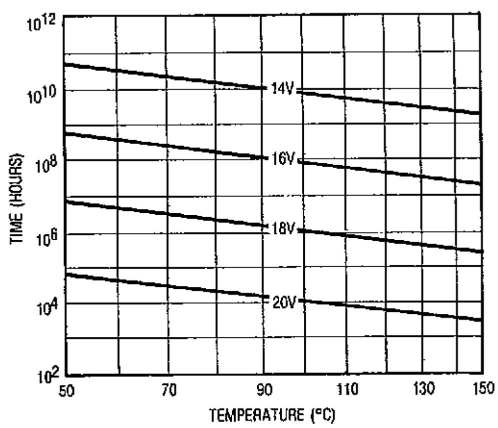

***Fig. 18 — Typical Time to Accumulated 1% Gate Failure**

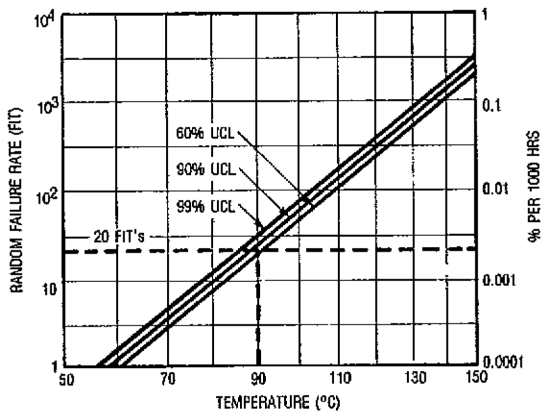

***Fig. 19 — Typical High Temperature Reverse Bias (HTRB) Failure Rate**

*The data shown in correct as of April 15, 1987. This information is updated on a quarterly basis; for the latest reliability data, please contact your local IR field office.

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